

Notice of References Cited	Application/Control No. 10/710,795		Applicant(s)/Patent Under Reexamination KUMER, GOPESH	
	Examiner ANTHONY MEJIA		Art Unit 2451	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,289,623	10-2007	Lurie, Steven	379/221.02
*	B	US-2004/0122941	06-2004	Creamer et al.	709/224
*	C	US-7,289,612	10-2007	Lurie et al.	379/114.1
*	D	US-6,493,437	12-2002	Olshansky, Robert	379/114.13
*	E	US-2002/0111907	08-2002	Ling, Marvin T.	705/41
*	F	US-6,463,149	10-2002	Jolissaint et al.	379/265.09
*	G	US-2005/0086290	04-2005	Joyce et al.	709/202
*	H	US-6,677,100	01-2004	Kim et al.	430/270.1
*	I	US-2002/0103693	08-2002	Bayer et al.	705/10
*	J	US-2004/0252820	12-2004	Faber et al.	379/201.12
*	K	US-6,907,116	06-2005	Ung et al.	379/114.16
*	L	US-6,058,173	05-2000	Penfield et al.	379/114.17
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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